

Notice of References Cited	Application/Control No. 10/667,542	Applicant(s)/Patent Under Reexamination DELINE ET AL.	
	Examiner Michael J. Yigdoll	Art Unit 2192	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,854,924	12-1998	Rickel et al.	717/132
*	B	US-2004/0230958	11-2004	Alaluf, Eyal	717/140
*	C	US-5,857,070	01-1999	Satterfield et al.	714/38
*	D	US-6,978,443	12-2005	Flanagan et al.	717/127
*	E	US-6,996,802	02-2006	de Jong, Eduard	717/107
*	F	US-7,024,661	04-2006	Leino et al.	717/126
*	G	US-2005/0015752	01-2005	Alpern et al.	717/131
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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